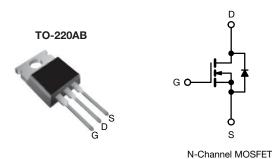


Q_{gd} (nC)

Configuration

Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	250			
R _{DS(on)} (Ω)	$V_{GS} = 10 \text{ V}$	0.28		
Q _g max. (nC)	68			
Q _{gs} (nC)	11			

35

Single

FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Note

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF644PbF
Lead (Pb)-free and halogen-free	IRF644PbF-BE3

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	250	V
Gate-source voltage			V_{GS}	± 20	V
Continuous drain current	V _{GS} at 10 V	T _C = 25 °C		14	
		T _C = 100 °C	ID	8.5	Α
Pulsed drain current a			I _{DM}	56	
Linear derating factor				1.0	W/°C
Single pulse avalanche energy b			E _{AS}	550	mJ
Repetitive avalanche current a			I _{AR}	14	Α
Repetitive avalanche energy ^a			E _{AR}	13	mJ
Maximum power dissipation	T _C = 25 °C		P_{D}	125	W
Peak diode recovery dV/dt ^c			dV/dt	4.8	V/ns
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) ^d	For	10 s		300	
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in
			Ī	1.1	N⋅m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 4.5 \, \text{mH}$, $R_q = 25 \, \Omega$, $I_{AS} = 14 \, \text{A}$ (see fig. 12)
- c. $I_{SD} \le 14$ A, $dI/dt \le 150$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	62	
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	1.0	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		250	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.34	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		-	4.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
7	,	V _{DS} = 250 V, V _{GS} = 0 V		-	-	25	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 200 V	V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8.4 A ^b	-	-	0.28	Ω
Forward transconductance	9 _{fs}	V _{DS} =	V _{DS} = 50 V, I _D = 8.4 A ^b		-	-	S
Dynamic					•		
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	1300	-	pF
Output capacitance	C _{oss}			-	330	-	
Reverse transfer capacitance	C _{rss}			-	85	-	
Total gate charge	Qg		I _D = 7.9 A, V _{DS} = 200 V, see fig. 6 and 13 ^b	-	-	68	nC
Gate-source charge	Q _{gs}	V _{GS} = 10 V		-	-	11	
Gate-drain charge	Q _{gd}	7		-	-	35	
Turn-on delay time	t _{d(on)}				11	-	ns
Rise time	t _r	V_{DD} = 125 V, I_{D} = 7.9 A, R_{g} = 9.1 Ω, R_{D} = 8.7 Ω, see fig. 10 ^b		-	24	-	
Turn-off delay time	t _{d(off)}			-	53	-	
Fall time	t _f			-	49	-	
Gate input resistance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal drain inductance	L _S			-	7.5	-	
Internal source inductance	R _g	f = 1 MHz, open drain		0.3	-	1.2	Ω
Drain-Source Body Diode Characteristic	es						
Continuous source-drain diode current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14	
Pulsed diode forward current ^a	I _{SM}			-	-	56	A
Body diode voltage	V _{SD}	T _J = 25 °C, I _S = 14 A, V _{GS} = 0 V ^b		-	-	1.8	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = 7.9 A, dI/dt = 100 A/μs b		-	250	500	ns
Body diode reverse recovery charge	Q _{rr}			-	2.3	4.6	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and			v L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

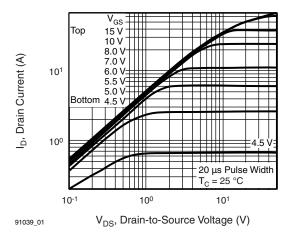


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

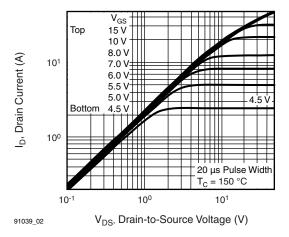


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

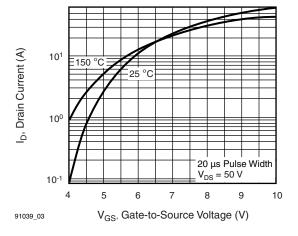


Fig. 3 - Typical Transfer Characteristics

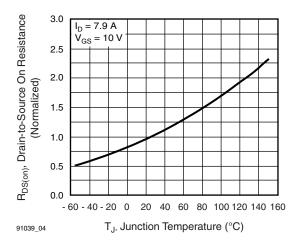


Fig. 4 - Normalized On-Resistance vs. Temperature

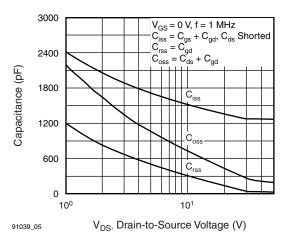


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

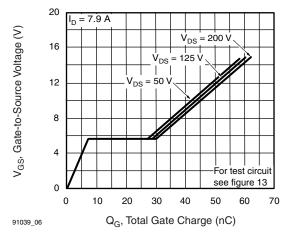


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



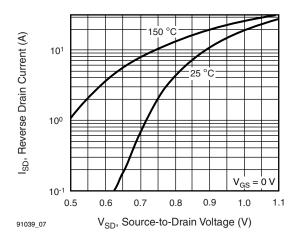


Fig. 7 - Typical Source-Drain Diode Forward Voltage

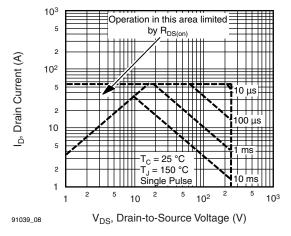


Fig. 8 - Maximum Safe Operating Area

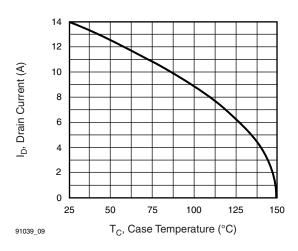


Fig. 9 - Maximum Drain Current vs. Case Temperature

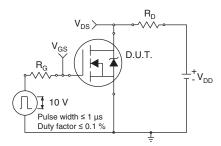


Fig. 10a - Switching Time Test Circuit

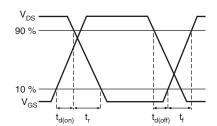


Fig. 10b - Switching Time Waveforms

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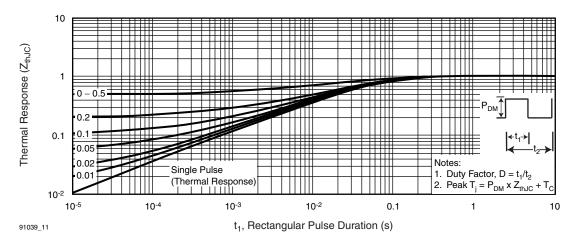
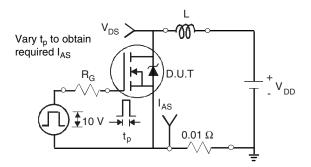


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





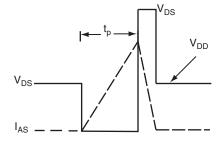


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

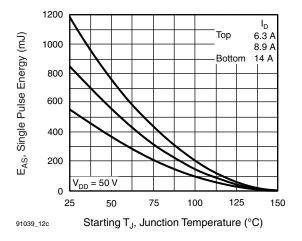


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

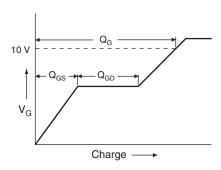


Fig. 13a - Basic Gate Charge Waveform

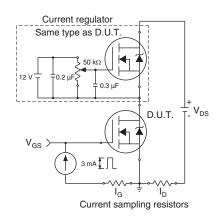
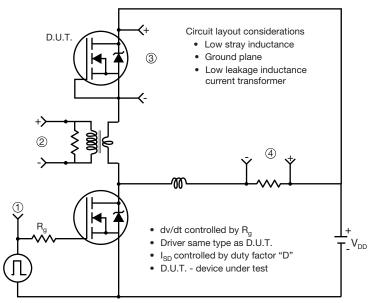


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit



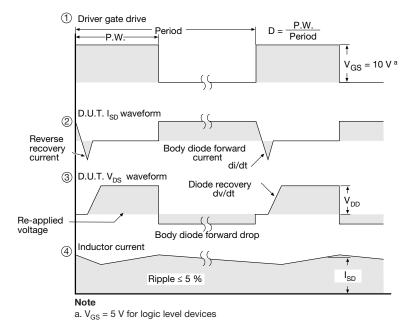


Fig. 14 - For N-Channel

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